

<b>Notice of References Cited</b>	Application/Control No. 10/777,750		Applicant(s)/Patent Under Reexamination WATANABE, MIKIO	
	Examiner Vincent Rudolph		Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0111493	06-2004	Yamaguchi et al.	709/219
*	B	US-2003/0053124	03-2003	Iijima et al.	358/1.15
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**FOREIGN PATENT DOCUMENTS**

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